

PowerMOS transistor TOPFET

BUK101-50GS

DESCRIPTION

Monolithic temperature and overload protected power MOSFET in a 3 pin plastic envelope, intended as a general purpose switch for automotive systems and other applications.

APPLICATIONS

General controller for driving

- lamps
- motors
- solenoids
- heaters

FEATURES

- Vertical power DMOS output stage
- Low on-state resistance
- Overload protection against over temperature
- Overload protection against short circuit load
- Latched overload protection reset by input
- 10 V input level
- Low threshold voltage also allows 5 V control
- Control of power MOSFET and supply of overload protection circuits derived from input
- ESD protection on input pin
- Overvoltage clamping for turn off of inductive loads

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V_{DS}	Continuous drain source voltage	50	V
I_D	Continuous drain current	29	A
P_D	Total power dissipation	75	W
T_J	Continuous junction temperature	150	°C
$R_{DS(ON)}$	Drain-source on-state resistance	50	mΩ
	$V_{IS} = 10 \text{ V}$		

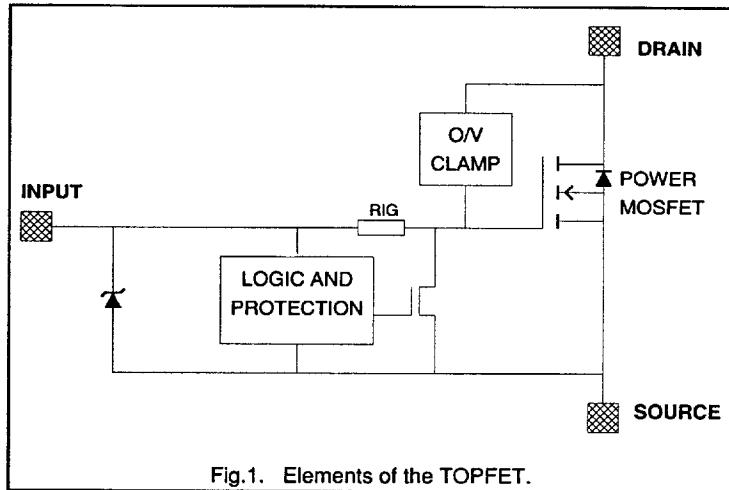
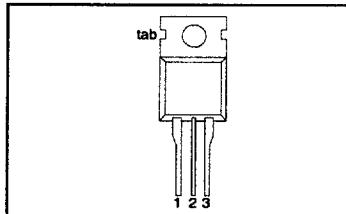
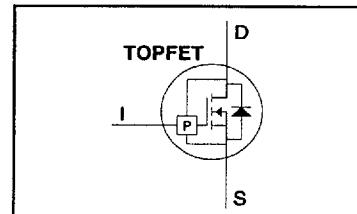
FUNCTIONAL BLOCK DIAGRAM

Fig.1. Elements of the TOPFET.

PINNING - TO220AB

PIN	DESCRIPTION
1	input
2	drain
3	source
tab	drain

PIN CONFIGURATION**SYMBOL**

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LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DSS}	Continuous off-state drain source voltage ¹	$V_{IS} = 0 \text{ V}$	-	50	V
V_{IS}	Continuous input voltage	-	0	11	V
I_D	Continuous drain current	$T_{mb} \leq 25^\circ\text{C}; V_{IS} = 10 \text{ V}$	-	29	A
I_D	Continuous drain current	$T_{mb} \leq 100^\circ\text{C}; V_{IS} = 10 \text{ V}$	-	18	A
I_{DROM}	Repetitive peak on-state drain current	$T_{mb} \leq 25^\circ\text{C}; V_{IS} = 10 \text{ V}$	-	120	A
P_D	Total power dissipation	$T_{mb} \leq 25^\circ\text{C}$	-	75	W
T_{sig}	Storage temperature	-	-55	150	°C
T_i	Continuous junction temperature ²	normal operation	-	150	°C
T_{sold}	Lead temperature	during soldering	-	250	°C

OVERLOAD PROTECTION LIMITING VALUES

With the protection supply provided via the input pin, TOPFET can protect itself from two types of overload.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{ISP}	Protection supply voltage ³	for valid protection	5	-	V
	Over temperature protection				
$V_{DDP(T)}$	Protected drain source supply voltage	$V_{IS} = 10 \text{ V}$	-	50	V
	Short circuit load protection				
$V_{DDP(P)}$	Protected drain source supply voltage ⁴	$V_{IS} = 10 \text{ V}$	-	20	V
E_{DSM}	Instantaneous overload dissipation	$V_{IS} = 5 \text{ V}$ $T_{mb} = 25^\circ\text{C}$	-	35	V
			-	1.3	kW

OVERVOLTAGE CLAMPING LIMITING VALUES

At a drain source voltage above 50 V the power MOSFET is actively turned on to clamp overvoltage transients.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I_{DROM}	Repetitive peak clamping current	$V_{IS} = 0 \text{ V}$	-	29	A
E_{DSM}	Non-repetitive clamping energy	$T_{mb} \leq 25^\circ\text{C}; I_{DM} = 27 \text{ A}; V_{DD} \leq 20 \text{ V};$ inductive load	-	625	mJ
E_{DRM}	Repetitive clamping energy	$V_{DD} \leq 20 \text{ V}; f = 250 \text{ Hz}$	-	40	mJ

ESD LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_C	Electrostatic discharge capacitor voltage	Human body model; $C = 250 \text{ pF}; R = 1.5 \text{ k}\Omega$	-	2	kV

1 Prior to the onset of overvoltage clamping. For voltages above this value, safe operation is limited by the overvoltage clamping energy.

2 A higher T_i is allowed as an overload condition but at the threshold $T_{(TO)}$ the over temperature trip operates to protect the switch.

3 The input voltage for which the overload protection circuits are functional.

4 The device is able to self-protect against a short circuit load providing the drain-source supply voltage does not exceed $V_{DD(P)}$ maximum.
For further information, refer to OVERLOAD PROTECTION CHARACTERISTICS.

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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th,j-mb}$	Thermal resistance Junction to mounting base	-	-	1.3	1.67	K/W
$R_{th,j-a}$	Junction to ambient in free air	-	-	60	-	K/W

STATIC CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(CL)DSS}$	Drain-source clamping voltage	$V_{IS} = 0 \text{ V}; I_D = 10 \text{ mA}$	50	-	-	V
$V_{(CL)DSS}$	Drain-source clamping voltage	$V_{IS} = 0 \text{ V}; I_{DM} = 2 \text{ A}; t_p \leq 300 \mu\text{s}; \delta \leq 0.01$	-	-	70	V
I_{DSS}	Zero input voltage drain current	$V_{DS} = 12 \text{ V}; V_{IS} = 0 \text{ V}$	-	0.5	10	μA
I_{DSS}	Zero input voltage drain current	$V_{DS} = 50 \text{ V}; V_{IS} = 0 \text{ V}$	-	1	20	μA
I_{DSS}	Zero input voltage drain current	$V_{DS} = 40 \text{ V}; V_{IS} = 0 \text{ V}; T_j = 125^\circ\text{C}$	-	10	100	μA
$R_{DS(on)}$	Drain-source on-state resistance	$I_{DM} = 13 \text{ A}; t_p \leq 300 \mu\text{s}; \delta \leq 0.01$	-	35	50	$\text{m}\Omega$
		$V_{IS} = 10 \text{ V}$	-	45	60	$\text{m}\Omega$
		$V_{IS} = 5 \text{ V}$	-			

OVERLOAD PROTECTION CHARACTERISTICS

TOPFET switches off when one of the overload thresholds is reached. It remains latched off until reset by the input.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$E_{D(S)(TO)}$ $t_{d sc}$	Short circuit load protection ¹ Overload threshold energy Response time	$T_{mb} = 25^\circ\text{C}; L \leq 10 \mu\text{H}$ $V_{DD} = 13 \text{ V}; V_{IS} = 10 \text{ V}$ $V_{DD} = 13 \text{ V}; V_{IS} = 10 \text{ V}$	-	0.4	-	J
$T_{j(TO)}$	Over temperature protection Threshold junction temperature	$V_{IS} = 10 \text{ V}; \text{from } I_D \geq 1 \text{ A}^2$	-	0.8	-	ms
		$V_{IS} = 10 \text{ V}; \text{from } I_D \geq 1 \text{ A}^2$	150	-	-	°C

INPUT CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$ unless otherwise specified. The supply for the logic and overload protection is taken from the input.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{IS(TO)}$ I_{IS}	Input threshold voltage Input supply current	$V_{DS} = 5 \text{ V}; I_D = 1 \text{ mA}$ $V_{IS} = 10 \text{ V}; \text{normal operation}$	1.0	1.5	2.0	V
V_{ISR}	Protection reset voltage ³		-	0.4	1.0	mA
V_{ISR}	Protection reset voltage	$T_j = 150^\circ\text{C}$	2.0	2.6	3.5	V
I_{ISL} $V_{(BR)IS}$ R_{IG}	Input supply current Input clamp voltage Input series resistance	$V_{IS} = 10 \text{ V}; \text{protection latched}$ $I_I = 10 \text{ mA}$ to gate of power MOSFET	1.0	-	-	
			11	2.5	4.0	mA
			-	13	-	V
			-	4	-	$\text{k}\Omega$

1 The short circuit load protection is able to save the device providing the instantaneous on-state dissipation is less than the limiting value for P_{DSW} , which is always the case when V_{DS} is less than $V_{DS(\text{max})}$. Refer to OVERLOAD PROTECTION LIMITING VALUES.

2 The over temperature protection feature requires a minimum on-state drain source voltage for correct operation. The specified minimum I_D ensures this condition.

3 The input voltage below which the overload protection circuits will be reset.

Philips Semiconductors

Product Specification

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BUK101-50GS**TRANSFER CHARACTERISTICS** $T_{mb} = 25^\circ\text{C}$

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
g_{fs}	Forward transconductance	$V_{DS} = 10 \text{ V}; I_{DM} = 13 \text{ A}$; $t_p \leq 300 \mu\text{s}$; $\delta \leq 0.01$	10	16	-	S
$I_{D(SC)}$	Drain current ¹	$V_{DS} = 13 \text{ V}; V_{IS} = 10 \text{ V}$	-	80	-	A

SWITCHING CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$. $R_L = 50 \Omega$. Refer to waveform figures and test circuits.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 13 \text{ V}; V_{IS} = 10 \text{ V}$ resistive load $R_L = 2.1 \Omega$	-	1.5	-	μs
t_r	Rise time		-	6	-	μs
$t_{d(off)}$	Turn-off delay time	$V_{DD} = 13 \text{ V}; V_{IS} = 0 \text{ V}$ resistive load $R_L = 2.1 \Omega$	-	18	-	μs
t_f	Fall time		-	9	-	μs
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 10 \text{ V}; V_{IS} = 10 \text{ V}$ inductive load $I_{DM} = 6 \text{ A}$	-	2	-	μs
t_r	Rise time		-	1	-	μs
$t_{d(off)}$	Turn-off delay time	$V_{DD} = 10 \text{ V}; V_{IS} = 0 \text{ V}$ inductive load $I_{DM} = 6 \text{ A}$	-	22	-	μs
t_f	Fall time		-	1	-	μs

REVERSE DIODE LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I_s	Continuous forward current	$T_{mb} \leq 25^\circ\text{C}; V_{IS} = 0 \text{ V}$	-	29	A

REVERSE DIODE CHARACTERISTICS $T_{mb} = 25^\circ\text{C}$

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{SDS}	Forward voltage	$I_s = 29 \text{ A}; V_{IS} = 0 \text{ V}; t_p = 300 \mu\text{s}$	-	1.0	1.5	V
t_{rr}	Reverse recovery time	not applicable ²	-	-	-	-

ENVELOPE CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
L_d	Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nH
L_d	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	4.5	-	nH
L_s	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	7.5	-	nH

¹ During overload before short circuit load protection operates.² The reverse diode of this type is not intended for applications requiring fast reverse recovery.

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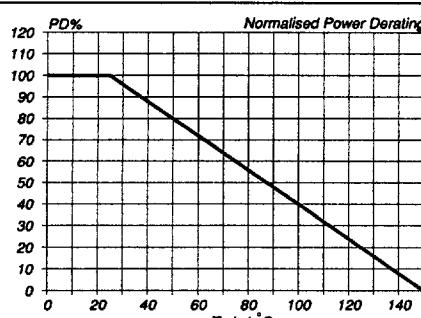


Fig.2. Normalised limiting power dissipation.
 $P_0\% = 100 \cdot P_d/P_d(25^\circ\text{C}) = f(T_{mb})$

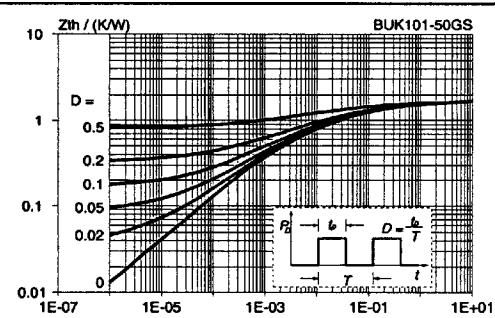


Fig.5. Transient thermal impedance.
 $Z_{th, T_{mb}} = f(t); \text{parameter } D = t_p/T$

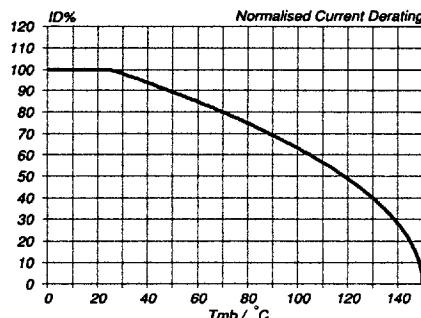


Fig.3. Normalised continuous drain current.
 $I_D\% = 100 \cdot I_D/I_D(25^\circ\text{C}) = f(T_{mb}); \text{conditions: } V_{IS} = 5 \text{ V}$

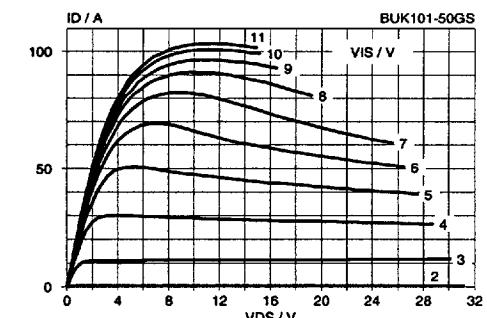


Fig.6. Typical output characteristics, $T_j = 25^\circ\text{C}$.
 $ID = f(V_{DS}); \text{parameter } V_{IS}; t_p = 250 \mu\text{s} \& t_p < t_{dsc}$

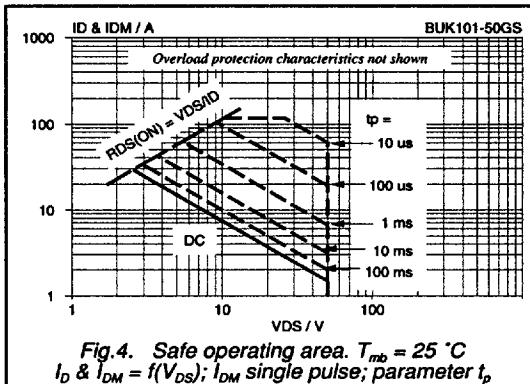


Fig.4. Safe operating area. $T_{mb} = 25^\circ\text{C}$
 $I_D \& I_{DM} = f(V_{DS}); I_{DM} \text{ single pulse; parameter } t_p$

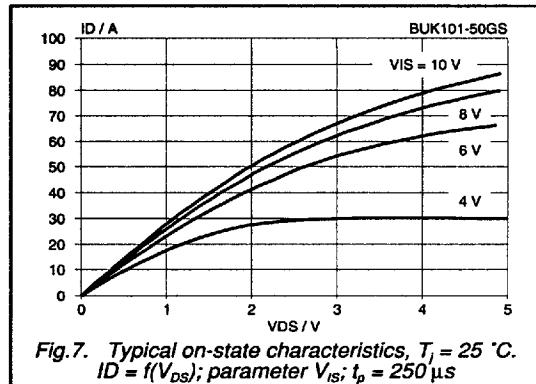


Fig.7. Typical on-state characteristics, $T_j = 25^\circ\text{C}$.
 $ID = f(V_{DS}); \text{parameter } V_{IS}; t_p = 250 \mu\text{s}$

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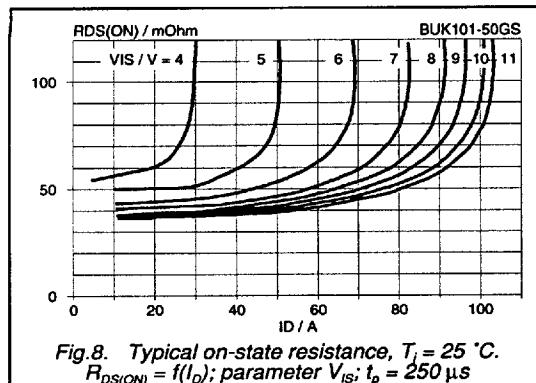


Fig.8. Typical on-state resistance, $T_j = 25^\circ\text{C}$.
 $R_{DS(\text{ON})} = f(I_D)$; parameter $V_{IS} = 10\text{ V}$; $t_p = 250\ \mu\text{s}$

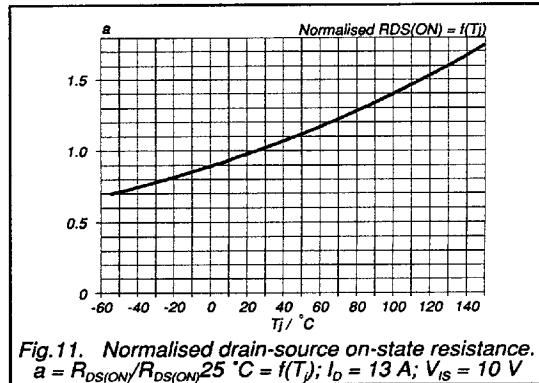


Fig.11. Normalised drain-source on-state resistance.
 $a = R_{DS(\text{ON})}/R_{DS(\text{ON})}(25^\circ\text{C}) = f(T_j)$; $I_D = 13\text{ A}$; $V_{IS} = 10\text{ V}$

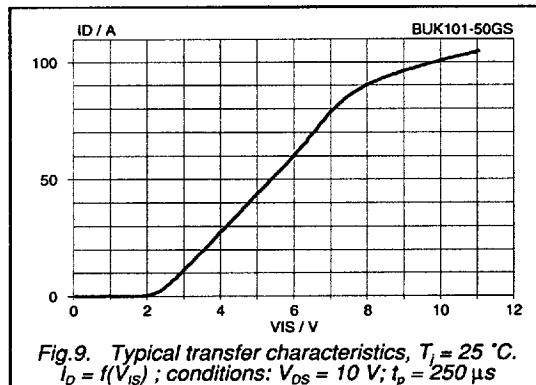


Fig.9. Typical transfer characteristics, $T_j = 25^\circ\text{C}$.
 $I_D = f(V_{DS})$; conditions: $V_{DS} = 10\text{ V}$; $t_p = 250\ \mu\text{s}$

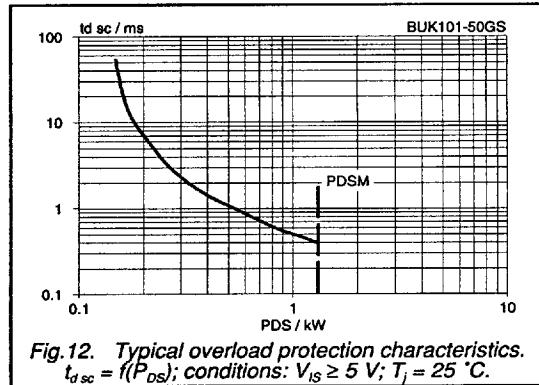


Fig.12. Typical overload protection characteristics.
 $t_{d\ sc} = f(P_{DSM})$; conditions: $V_{IS} \geq 5\text{ V}$; $T_j = 25^\circ\text{C}$.

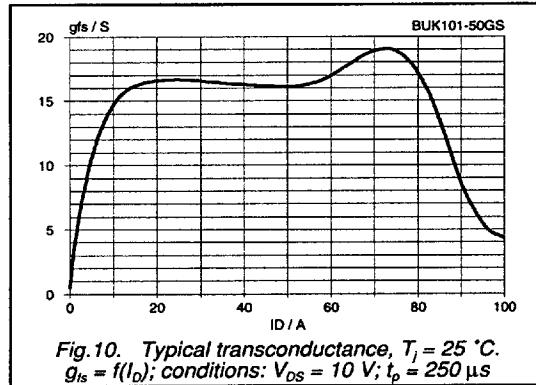


Fig.10. Typical transconductance, $T_j = 25^\circ\text{C}$.
 $g_{fs} = f(I_D)$; conditions: $V_{DS} = 10\text{ V}$; $t_p = 250\ \mu\text{s}$

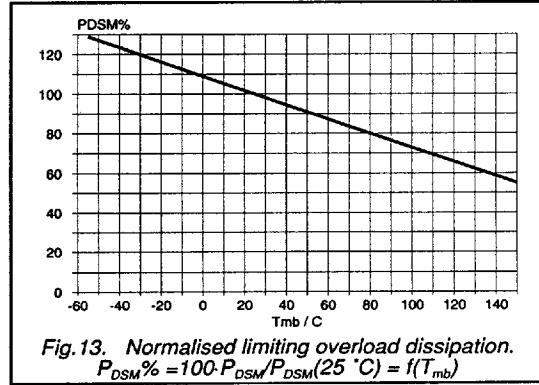


Fig.13. Normalised limiting overload dissipation.
 $P_{DSM\%} = 100 \cdot P_{DSM}/P_{DSM}(25^\circ\text{C}) = f(T_{mb})$

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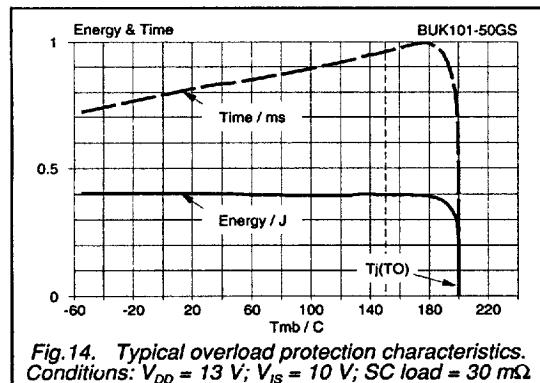


Fig. 14. Typical overload protection characteristics.
Conditions: $V_{DD} = 13 \text{ V}$; $V_{IS} = 10 \text{ V}$; SC load = $30 \text{ m}\Omega$

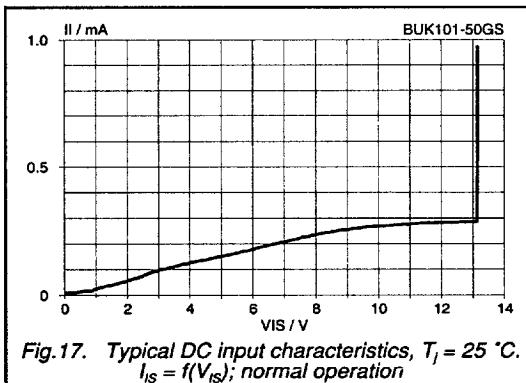


Fig. 17. Typical DC input characteristics, $T_J = 25 \text{ }^{\circ}\text{C}$.
 $I_{IS} = f(V_{IS})$; normal operation

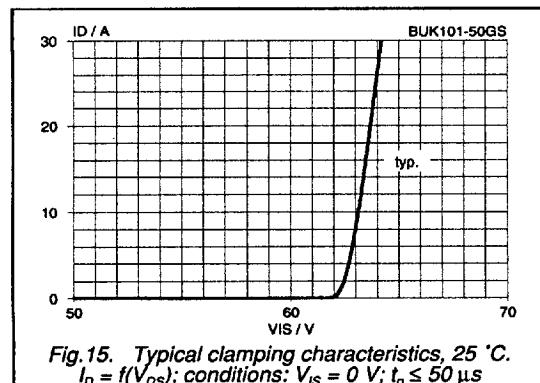


Fig. 15. Typical clamping characteristics, $25 \text{ }^{\circ}\text{C}$.
 $I_D = f(V_{DS})$; conditions: $V_{IS} = 0 \text{ V}$; $t_p \leq 50 \mu\text{s}$

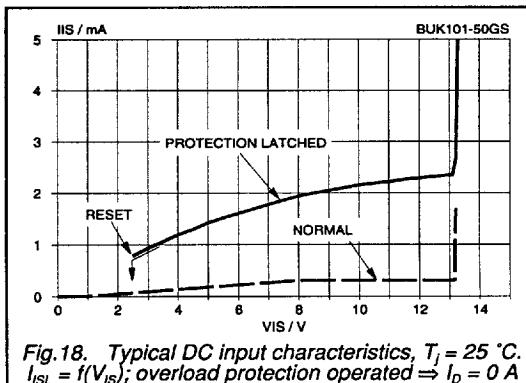


Fig. 18. Typical DC input characteristics, $T_J = 25 \text{ }^{\circ}\text{C}$.
 $I_{ISL} = f(V_{IS})$; overload protection operated $\Rightarrow I_D = 0 \text{ A}$

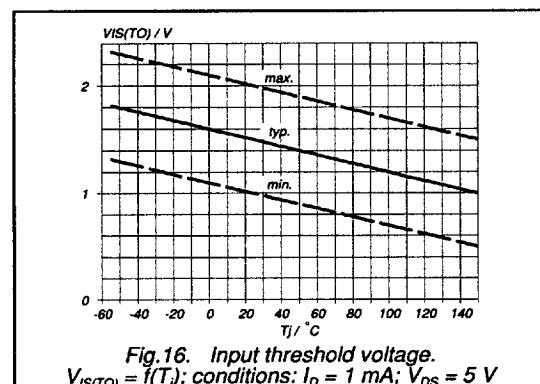


Fig. 16. Input threshold voltage.
 $V_{IS(TO)} = f(T_J)$; conditions: $I_D = 1 \text{ mA}$; $V_{DS} = 5 \text{ V}$

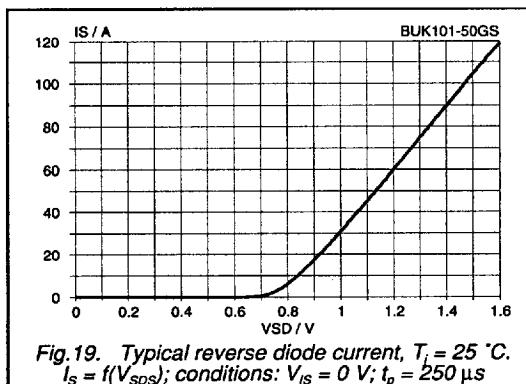


Fig. 19. Typical reverse diode current, $T_J = 25 \text{ }^{\circ}\text{C}$.
 $I_S = f(V_{SD})$; conditions: $V_{IS} = 0 \text{ V}$; $t_p = 250 \mu\text{s}$

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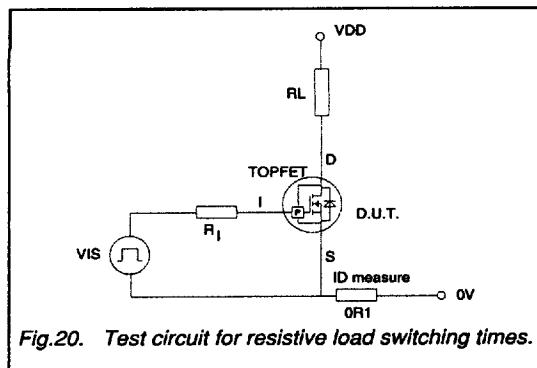


Fig.20. Test circuit for resistive load switching times.

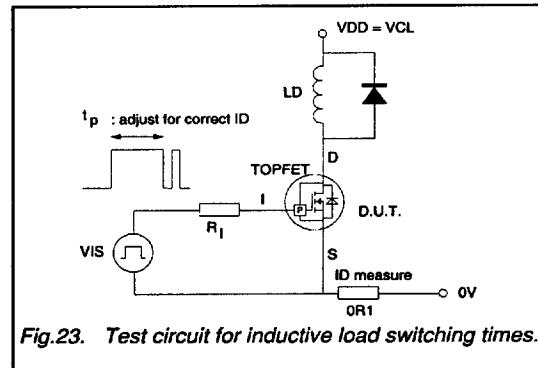


Fig.23. Test circuit for inductive load switching times.

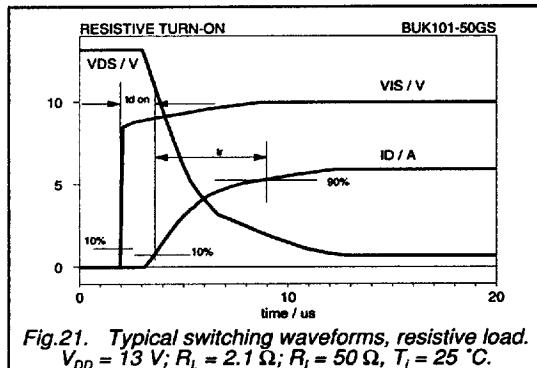


Fig.21. Typical switching waveforms, resistive load.
 $V_{DD} = 13 \text{ V}$; $R_L = 2.1 \Omega$; $R_I = 50 \Omega$, $T_j = 25^\circ\text{C}$.

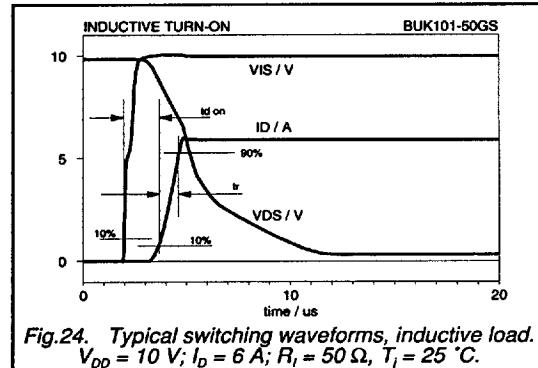


Fig.24. Typical switching waveforms, inductive load.
 $V_{DD} = 10 \text{ V}$; $I_D = 6 \text{ A}$; $R_L = 50 \Omega$, $T_j = 25^\circ\text{C}$.

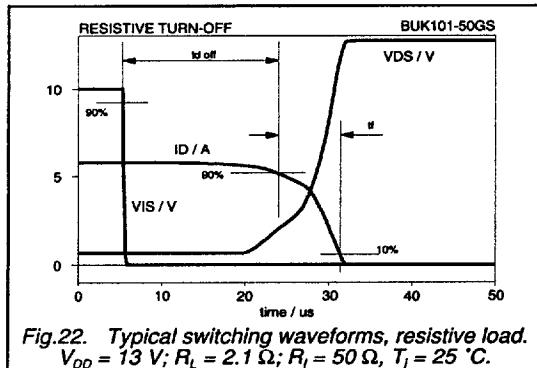


Fig.22. Typical switching waveforms, resistive load.
 $V_{DD} = 13 \text{ V}$; $R_L = 2.1 \Omega$; $R_I = 50 \Omega$, $T_j = 25^\circ\text{C}$.

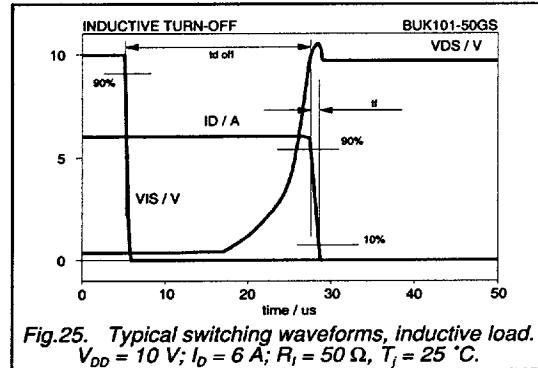


Fig.25. Typical switching waveforms, inductive load.
 $V_{DD} = 10 \text{ V}$; $I_D = 6 \text{ A}$; $R_L = 50 \Omega$, $T_j = 25^\circ\text{C}$.

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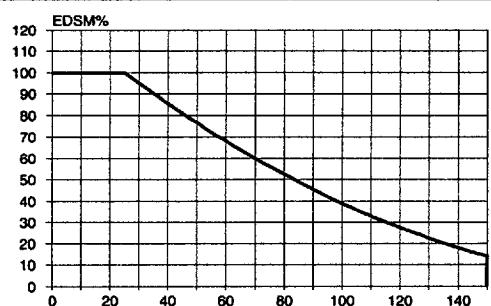


Fig.26. Normalised limiting clamping energy,
 $E_{DSM\%} = f(T_{mb})$; conditions: $I_D = 27 \text{ A}$; $V_{IS} = 10 \text{ V}$

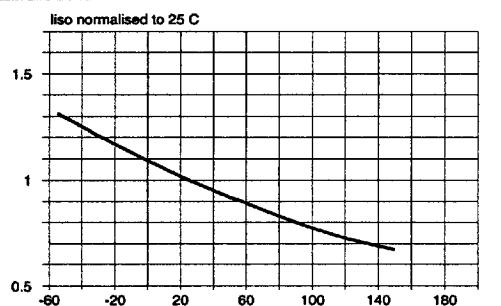


Fig.29. Normalised input current (normal operation),
 $l_{IS}/l_{IS,25\text{ }^{\circ}\text{C}} = f(T_J)$; $V_{IS} = 10 \text{ V}$

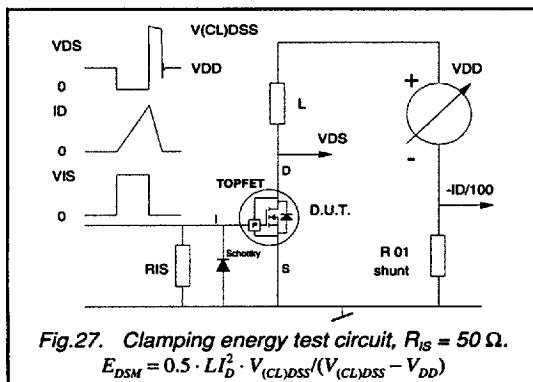


Fig.27. Clamping energy test circuit, $R_{IS} = 50 \Omega$.
 $E_{DSM} = 0.5 \cdot L I_D^2 \cdot V_{(CL)DSS} / (V_{(CL)DSS} - V_{DD})$

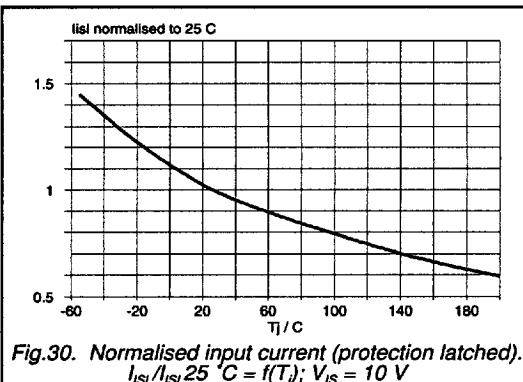


Fig.30. Normalised input current (protection latched),
 $l_{ISL}/l_{ISL,25\text{ }^{\circ}\text{C}} = f(T_J)$; $V_{IS} = 10 \text{ V}$

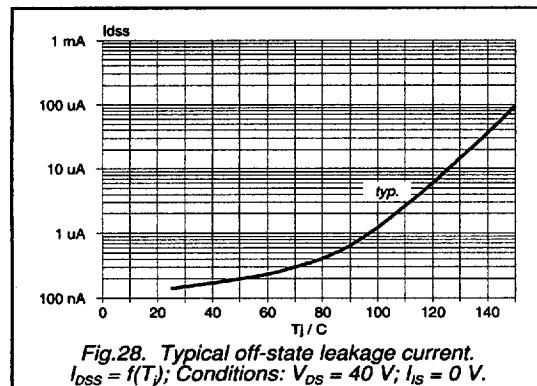


Fig.28. Typical off-state leakage current.
 $I_{DSS} = f(T_J)$; Conditions: $V_{DS} = 40 \text{ V}$; $I_{IS} = 0 \text{ V}$.

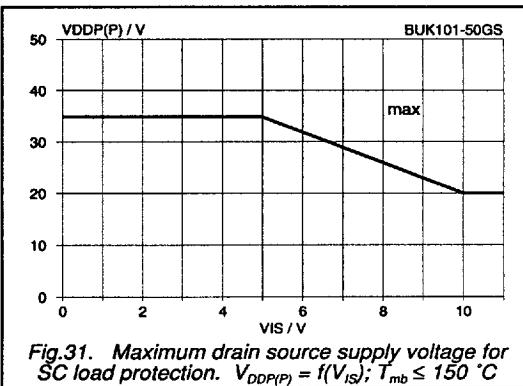


Fig.31. Maximum drain source supply voltage for
SC load protection. $V_{DDP(P)} = f(V_{IS})$; $T_{mb} \leq 150 \text{ }^{\circ}\text{C}$